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Patent and Trademark

Atty. Docket No.:

Serial No.:

FMW-XX-PCT-US

## LIST OF PRIOR ART CITED BY APPLICANT

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Applicant:  
Lutz WeberFiling Date:  
March 8, 2002

Group:

## U.S. PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing date if appropriate
an	AA	5,201,348	April 13, 1993	Lurz			
an	AB	5,306,467	April 26, 1994	Douglas-Hamilton et al.			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

## FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	Class	Subclass	Translation Yes No
an	AL	02092275	April 3, 1990	Japanese Abstract			
an	AM	60007340	January 16, 1985	Japanese Abstract			
a	AN	197 09 136	September 10, 1998	Germany			
	AO						
	AP						

## OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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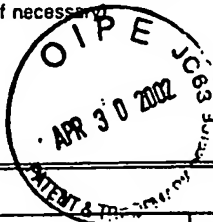
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	Applicant: Lutz Weber	Examiner:
	Filing Date: March 8, 2002	Group:



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	AL						
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**OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)**

an	AR	Challenges and Opportunities in High Throughput Screening: Implications for New Technologies, Journal of Biomolecular Screening, Vol. 3, Number 1, John Major, (1998); pp. 13-17.
	AS	

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Atty. Docket No.:

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an	AL	41 07 262 A1	September 10, 1992	DE			
an	AM	197 39 119 A1	March 11, 1999	DE			
an	AN	298 17 526 U1	May 12, 1999	DE			
an	AO	298 05 613 U1	July 9, 1998	DE			
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## OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

an	AR	Patents Abstracts of Japan, Vol. 15, No. 71 February 19, 1991; Abstract No. 2-293642, "PLATE SAMPLE HOLDER FOR TOTAL REFLECTION FLUORESCENT X-RAY ANALYSIS" P-1168
an	AS	Patents Abstracts of Japan, Vol. 17, No. 138 March 22, 1993; Abstract No. 4-313045, "SAMPLE SUPPORTING DEVICE OF X-RAY DIFFRACTION APPARATUS" P-1505
an	AT	Patents Abstracts of Japan, Publication No. 09061319A, Published March 7, 1997 "SUCTION TYPE SAMPLE BASE"

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